

<b>Notice of References Cited</b>	Application/Control No. 10/823,341		Applicant(s)/Patent Under Reexamination OHMURA ET AL.	
	Examiner Mark A. Chapman		Art Unit 1756	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,821,695	11-2004	Matsushima et al.	430/108.1
*	B	US-2003/0129519	07-2003	Ishibashi et al.	430/137.14
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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